

Description

The AP45P06D uses advanced trench technology to provide excellent R_{DS(ON)}, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

 $V_{DS} = -60V I_{D} = -45A$

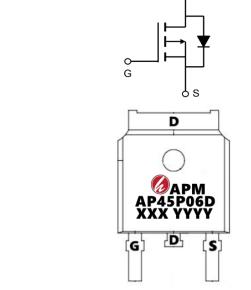
 $R_{DS(ON)} < -25m\Omega$ @ V_{GS} =-10V (Type: 20m Ω)

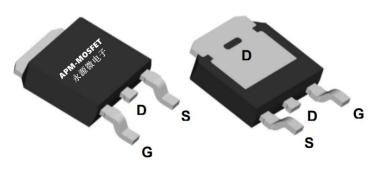
Application

Lithium battery protection

Wireless impact

Mobile phone fast charging





Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
AP45P06D	TO-252-3L	AP45P06D XXX YYYY	2500

Absolute Maximum Ratings (T_C=25°Cunless otherwise noted)

Symbol	Parameter	Rating	Units
VDS	Drain-Source Voltage	-60	V
VGS	Gate-Source Voltage	±20	V
I _D @T _C =25°C	Continuous Drain Current, -V _{GS} @ -10V ¹	-45	Α
I _D @T _C =100°C	Continuous Drain Current, -V _{GS} @ -10V ¹	-28	А
IDM	Pulsed Drain Current ²	-85	А
EAS	Single Pulse Avalanche Energy ³	113	mJ
IAS	Avalanche Current	47.6	Α
P _D @T _C =25°C	Total Power Dissipation ⁴	52.1	W
TSTG	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
R _θ JA	Thermal Resistance Junction-Ambient ¹	62.5	°C/W
$R_{\theta}JC$	Thermal Resistance Junction-Case ¹	2.4	°C/W



Electrical Characteristics (Tc=25℃unless otherwise noted)

Symbol	Parameter Conditions		Min.	Тур.	Max.	Unit	
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =-250uA	-60	-68		V	
△BVDSS/△TJ	BV _{DSS} Temperature Coefficient	Reference to 25℃ , I _D =-1mA		-0.035		V/°C	
DDC(ON)	Static Drain-Source On-Resistance ²	V _{GS} =-10V , I _D =-10A		20	25	mΩ	
RDS(ON)	Static Dialit-Source Off-Resistance-	V _{GS} =-4.5V , I _D =-8A		26	33	11177	
VGS(th)	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =-250uA	-1.0	-1.6	-2.5	V	
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	VGS-VDS , ID2500A		4.28		mV/℃	
IDSS	Drain-Source Leakage Current	V_{DS} =-48V , V_{GS} =0V , T_{J} =25 $^{\circ}$ C		1			
1033	Diain-Source Leakage Current	V_{DS} =-48V , V_{GS} =0V , T_{J} =55 $^{\circ}$ C			5	uA	
IGSS	Gate-Source Leakage Current	V_{GS} =±20 V , V_{DS} =0 V			±100	nA	
gfs	Forward Transconductance	V _{DS} =-10V , I _D =-18A		23		S	
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		7		Ω	
Qg	Total Gate Charge (-4.5V)			25		nC	
Q _{gs}	Gate-Source Charge	V_{DS} =-20V , V_{GS} =-4.5V , I_{D} =-12A		6.7			
Q_{gd}	Gate-Drain Charge	1271		5.5			
Td(on)	Turn-On Delay Time			38			
Tr	Rise Time	V_{DD} =-15V , V_{GS} =-10V , R_{G} =3.3 Ω ,		23.6		ns	
Td(off)	Turn-Off Delay Time	I _D =-1A		100			
T _f	Fall Time	10174		6.8			
Ciss	Input Capacitance			3635			
Coss	Output Capacitance	V _{DS} =-15V , V _{GS} =0V , f=1MHz		224		pF	
Crss	Reverse Transfer Capacitance			141			
Is	Continuous Source Current ^{1,5}				-35	Α	
ISM	Pulsed Source Current ^{2,5}	- V _G =V _D =0V , Force Current			-70	Α	
VSD	Diode Forward Voltage ²	V _{GS} =0V , I _S =-1A , T _J =25℃			-1	V	

Note:

- 1、The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.
- 2、The data tested by pulsed , pulse width $\leqq 300 \text{us}$, duty cycle $\leqq 2\%$
- 3、The EAS data shows Max. rating . The test condition is VDD=-48V,VGS =-10V,L=0.1mH,IAS =-47.6A
- 4、The power dissipation is limited by 150°C junction temperature
- 5. The data is theoretically the same as I D and I DM , in real applications , should be limited by total power dissipation.



Typical Characteristics

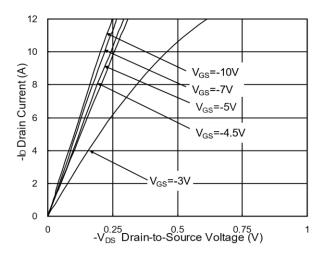


Fig.1 Typical Output Characteristics

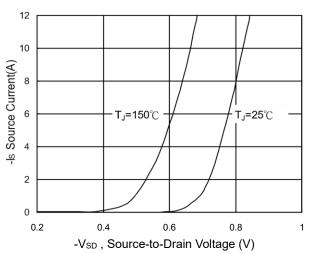


Fig.3 Forward Characteristics Of Reverse

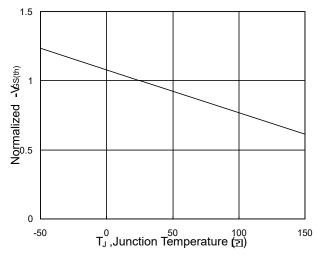


Fig.5 Normalized $V_{\text{GS(th)}}$ v.s T_{J}

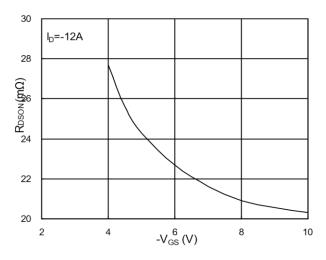


Fig.2 On-Resistance v.s Gate-Source

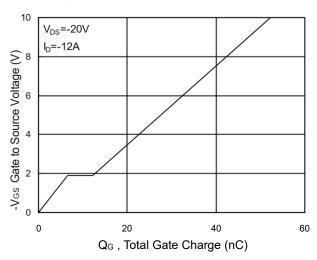


Fig.4 Gate-Charge Characteristics

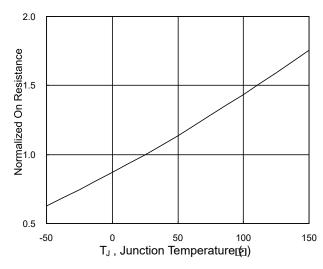
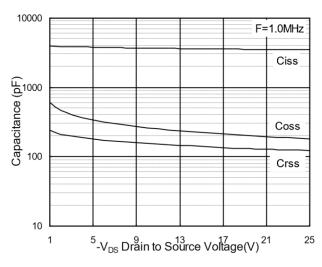
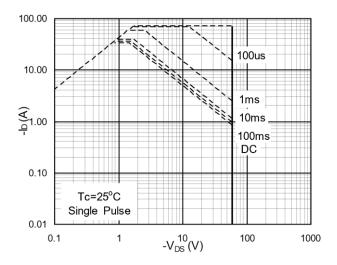


Fig.6 Normalized R_{DSON} v.s T_J









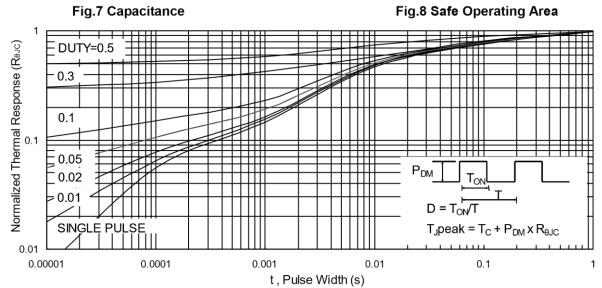
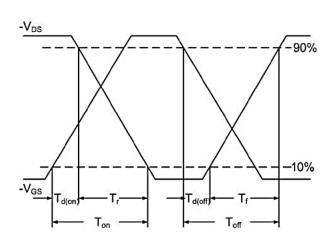
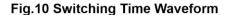


Fig.9 Normalized Maximum Transient Thermal Impedance





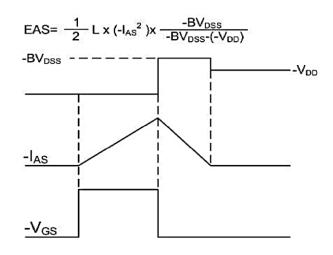
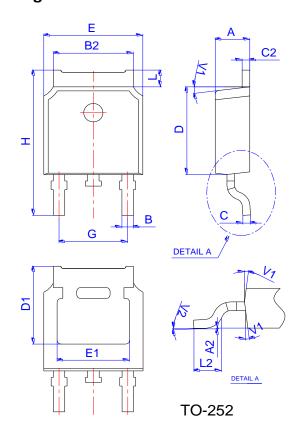


Fig.11 Unclamped Inductive Waveform



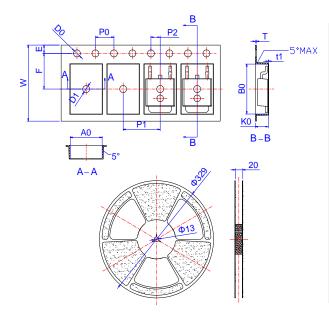


Package Mechanical Data:TO-252-3L



	Dimensions					
Ref.	Millimeters		Inches			
	Min.	Тур.	Max.	Min.	Тур.	Max.
Α	2.10		2.50	0.083		0.098
A2	0		0.10	0		0.004
В	0.66		0.86	0.026		0.034
B2	5.18		5.48	0.202		0.216
С	0.40		0.60	0.016		0.024
C2	0.44		0.58	0.017		0.023
D	5.90		6.30	0.232		0.248
D1	5.30REF			0.209REF		
E	6.40		6.80	0.252		0.268
E1	4.63			0.182		
G	4.47		4.67	0.176		0.184
Н	9.50		10.70	0.374		0.421
L	1.09		1.21	0.043		0.048
L2	1.35		1.65	0.053		0.065
V1		7°			7°	
V2	0°		6°	0°		6°

Reel Spectification-TO-252



	Dimensions					
Ref.	Millimeters			Inches		
	Min.	Тур.	Max.	Min.	Тур.	Max.
W	15.90	16.00	16.10	0.626	0.630	0.634
E	1.65	1.75	1.85	0.065	0.069	0.073
F	7.40	7.50	7.60	0.291	0.295	0.299
D0	1.40	1.50	1.60	0.055	0.059	0.063
D1	1.40	1.50	1.60	0.055	0.059	0.063
P0	3.90	4.00	4.10	0.154	0.157	0.161
P1	7.90	8.00	8.10	0.311	0.315	0.319
P2	1.90	2.00	2.10	0.075	0.079	0.083
A0	6.85	6.90	7.00	0.270	0.271	0.276
В0	10.45	10.50	10.60	0.411	0.413	0.417
K0	2.68	2.78	2.88	0.105	0.109	0.113
Т	0.24		0.27	0.009		0.011
t1	0.10			0.004		
10P0	39.80	40.00	40.20	1.567	1.575	1.583



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AP45P06D

-60V P-Channel Enhancement Mode MOSFET

Edition	Date	Change
Rve1.0	2021/1/31	Initial release

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